

Search Notes



Application/Control No.

10/764,644

Examiner

Thuy Pardo

Applicant(s)/Patent under Reexamination

CHEN ET AL.

Art Unit

2165

SEARCHED

Class	Subclass	Date	Examiner
707	3	7/1/05	15T
	5		
	10		
	101		
	102		
	103		
↓	104		
705	10		
↓	14		
345	236		
709	206	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
707	3	7/1/05	15T
	5		
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	101		
↓	102		
↓	103		
	104		
705	10		
↓	14		
345	236		
709	206	↓	↓

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
WEST IEEE	7/1/05	15T